

Trace Evidence Analysis Using PLM

Jeff Hollifield, MS

Chemical Microscopist/University Instructor 2019



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Advantages of Using PLM for Trace Evidence

- Versatility
- Limited Size and Amount of Sample
- Non-Destructive Technique
- Relative Cost of Analysis
- Much Information Obtained Quickly

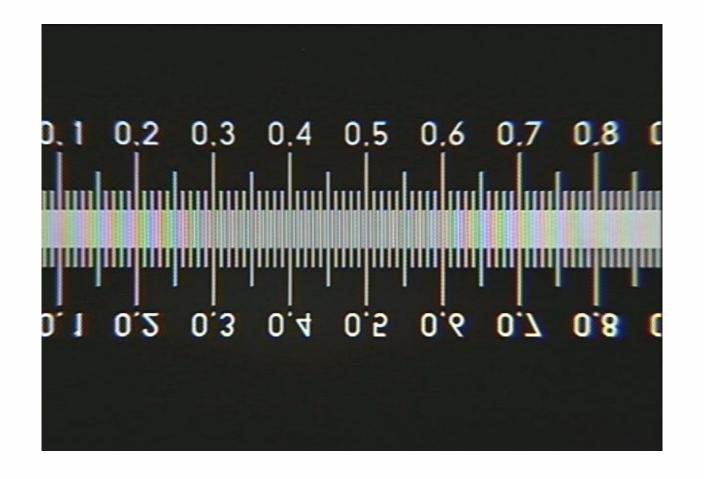


Optimizing the Microscope

- Microscope Components
- Mechanical Alignment
- Proper Illumination
- Image Formation
- Resolution and Magnification



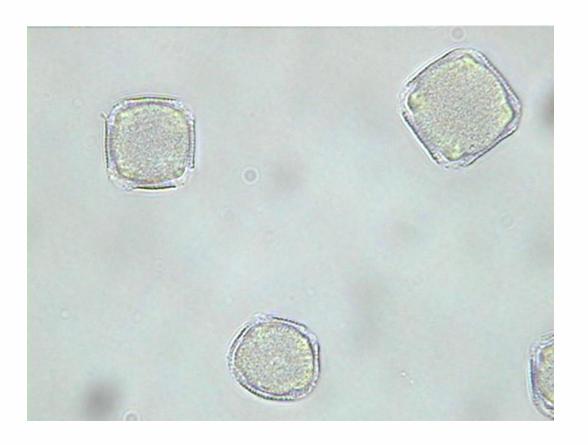
Micrometry



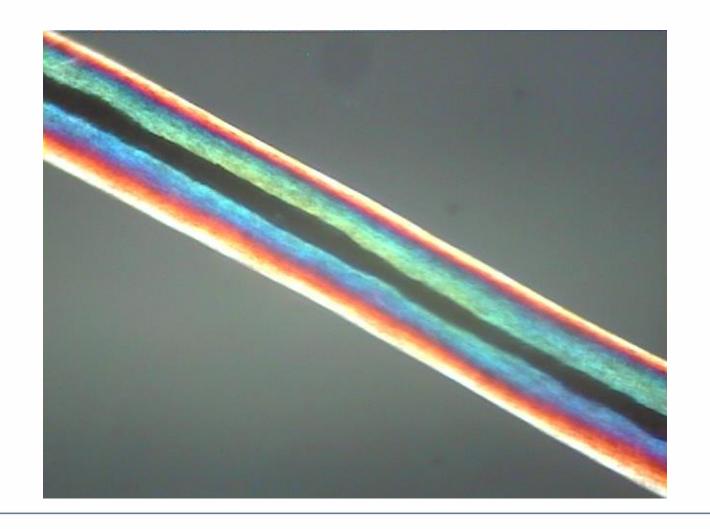


Starch Grains and Pollen





Analysis of Hair





Optical Measurements

- Geometrical Optics
- Snell's Law
 - Mathematical relationship between angle of propagation and refractive index
- Refractive Index
 - Ratio of speed of light in a vacuum to speed of light in the sample
 - Measured by immersion method

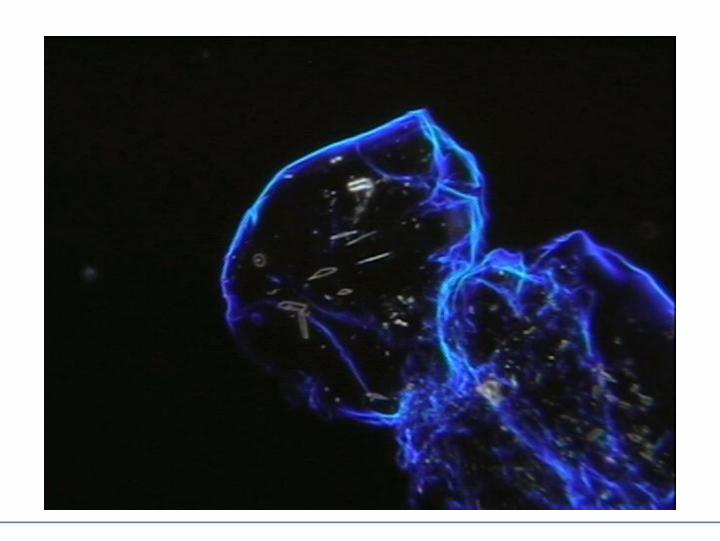


Sample Preparation

- Choosing a Mounting Medium
- Contrast Methods
- Dispersion Staining

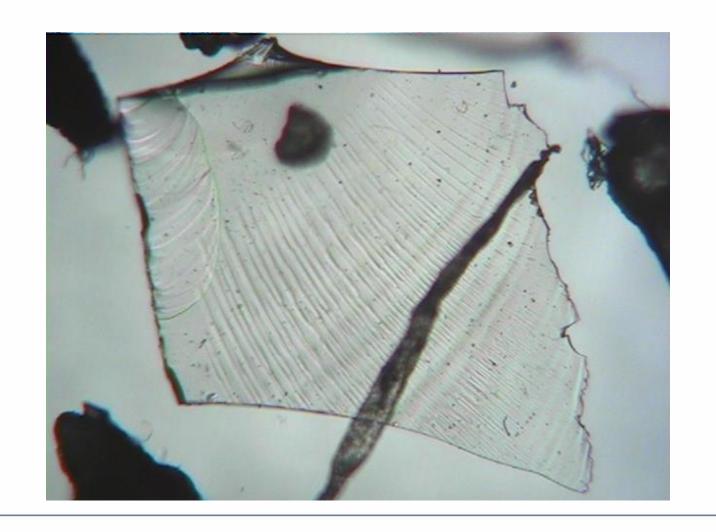


Dispersion Staining





Glass Analysis



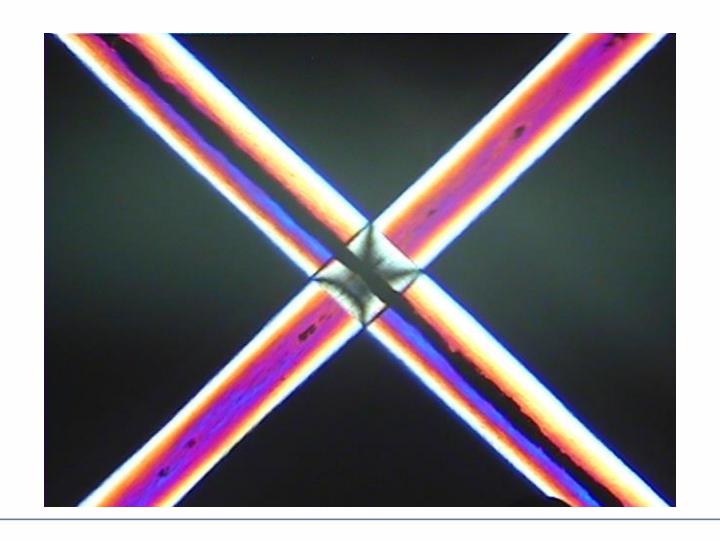


Crystal Morphology and Optical Characterization

- Retardation and Compensators
- Birefringence
- Sign of Elongation
- Optic Sign
- Extinction Angles
- Crystal Systems



Fiber Analysis



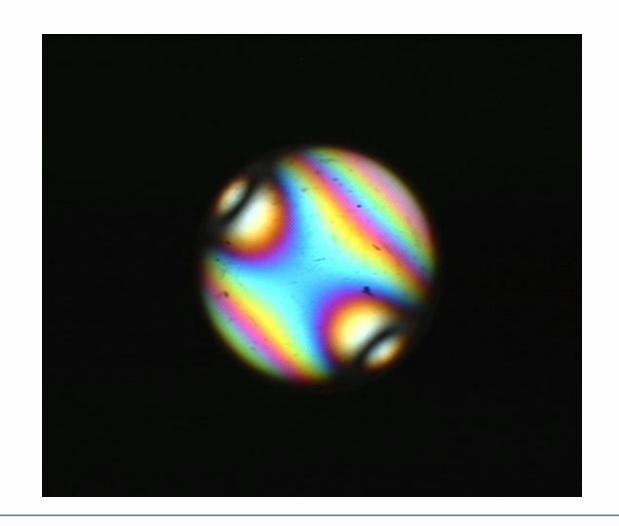


Conoscopy

• By inserting an additional lens (Bertrand Lens) into the light path, the microscope can be used to examine the behavior of light after it passes through a specimen.

 This is particularly useful for analyzing samples that are relatively large and flat, such as polymer films or certain mineral grains.

Interference Figure





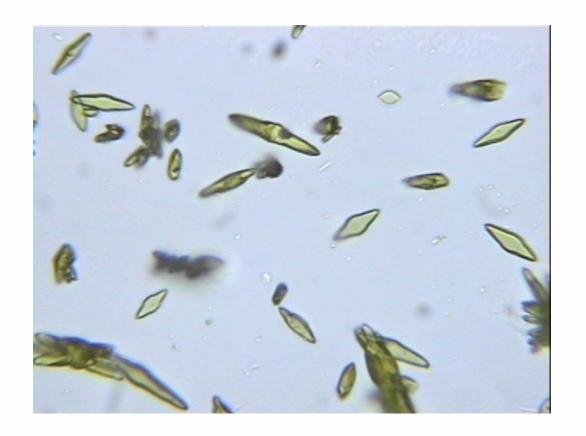
Paint Chip Analysis



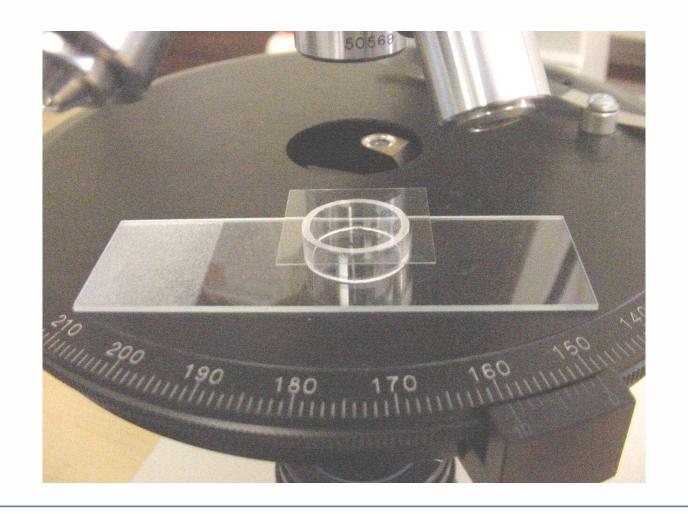


Microchemical Testing

- Solubilities
- Spot Tests
- Microcrystal Tests
- Use of Vapor Chamber



Vapor Chamber with Glass Ring





Ancillary Techniques

- Thermal Tests
- Using Circularly Polarized Light
- Slightly Uncrossed Polarizers
- Parallel Polarizers
- Opaque Samples



Reporting The Results

- Report Writing
- Court Testimony





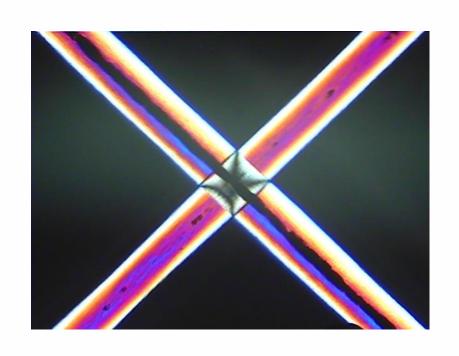
Thank you for joining us.

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Chemical Microscopist microanaly@aol.com • (630) 887-7100



Forensic Trace Evidence Course



Learn the principles and practical use of the stereomicroscope and polarized light microscope for the analysis of common microscopic trace evidence:

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microanaly@aol.com • (630) 887-7100

